# 2SK2211

## Silicon N-channel MOSFET

### For switching circuits

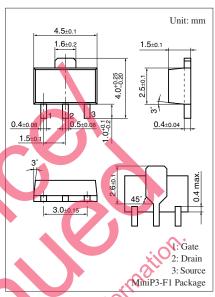
#### ■ Features

- Low ON resistance
- · High-speed switching
- Mini type package, allowing downsizing of the sets and automatic insertion through the magazine packing

## ■ Absolute Maximum Ratings $T_a = 25$ °C

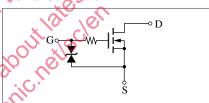
Parameter	Symbol	Rating	Unit	
Drain-source surrender voltage	V <sub>DSS</sub>	30	V	
Gate-source surrender voltage	V <sub>GSS</sub>	±20	V	
Drain current	$I_D$	1.0	A	
Peak drain current	$I_{DP}$	2.0	A	
Power dissipation *	$P_{\mathrm{D}}$	1.0	W	
Channel temperature	T <sub>ch</sub>	150	°C	
Storage temperature	$T_{\rm stg}$	-55 to +150	\°C	

Note) \*: PC board: Copper foil of the drain portion should have a area of 1  $cm^2$  or more and the board thickness should be 1.7 mm.  $P_C$  absolute maximum rating without a heat shink: 0.5 W



Marking Symbol: 2N

## Internal Connection



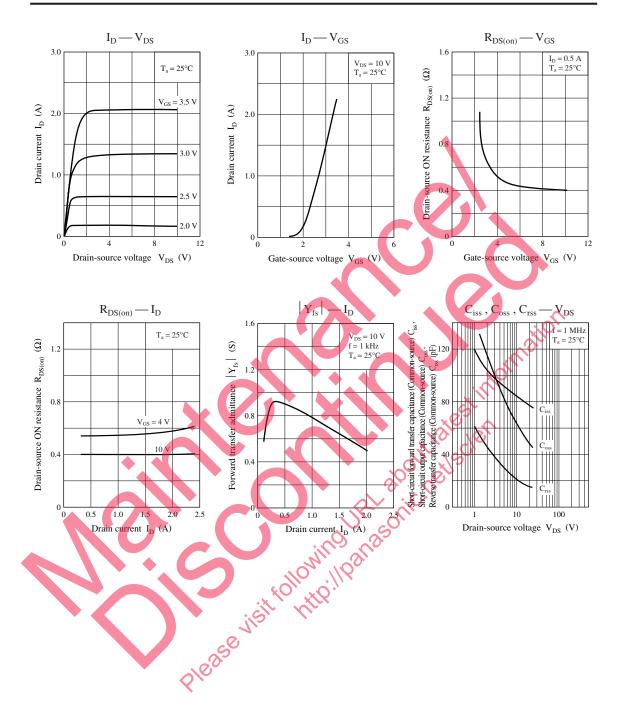
# ■ Electrical Characteristics $T_a = 25$ °C $\pm 3$ °C

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Drain-source surrender voltage	V <sub>DSS</sub>	$I_D = 0.1 \text{ mAl } V_{GS} = 0$	30			V
Gate-source surrender voltage	$V_{GSS}$	$I_{GS} = 0.1 \text{ mA}, V_{DS} = 0$	±20			V
Drain-source cutoff current	$I_{ m DSS}$	$V_{DS} = 25 \text{ V}, V_{GS} = 0$			10	μΑ
Gate-source cutoff current	I <sub>GSS</sub> ,	$V_{GS} = \pm 15 \text{ V}, V_{DS} = 0$			±10	μΑ
Gate threshold voltage	V <sub>th</sub>	$V_{DS} = 5 \text{ V}, I_D = 1 \text{ mA}$	0.8		2.0	V
Forward transfer admittance *	W <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_{D} = 0.5 \text{ A}$	0.5			S
Drain-source ON resistance *	R <sub>DS(on)1</sub>	$V_{GS} = 4 \text{ V}, I_D = 0.5 \text{ A}$		0.48	0.75	Ω
Ole	R <sub>DS(on)2</sub>	$V_{GS} = 10 \text{ V}, I_D = 0.5 \text{ A}$		0.35	0.60	
Short-circuit forward transfer capacitance (Common source)	C <sub>iss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$		87		pF
Short-circuit output capacitance (Common source)	C <sub>oss</sub>			69		pF
Reverse transfer capacitance (Common source)	C <sub>rss</sub>			23		pF
Turn-on delay time	t <sub>d(on)</sub>	$V_{GS} = 10 \text{ V}, V_{DD} = 10 \text{ V}, I_D = 0.5 \text{ A},$		12		ns
Fall time	$t_{\rm f}$	$R_L = 20 \Omega$		160		ns
Turn-off delay time	t <sub>d(off)</sub>			60		ns

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

2. \*: Pulse measurement

# **Panasonic**



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